

MOS FIELD EFFECT TRANSISTOR 2SK3297

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3297 is N-channel DMOS FET device that features a low gate charge and excellent switching characteristics, and designed for high voltage applications such as switching power supply, AC adapter.

ORDERING INFORMATION

PART NUMBER	PACKAGE		
2SK3297	Isolated TO-220		

FEATURES

•Low gate charge

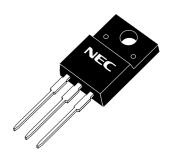
 $Q_G = 18 \text{ nC TYP.}$ ($V_{DD} = 450 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 5.0 \text{ A}$)

- •Gate voltage rating ±30 V
- •Low on-state resistance

RDS(ON) = 1.6Ω MAX. (VGS = 10 V, ID = 2.5 V)

- Avalanche capability ratings
- •Isolated TO-220 package

(Isolated TO-220)



ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	600	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±30	V
Drain Current(DC) (Tc = 25°C)	I _{D(DC)}	±5.0	Α
Drain Current(pulse) Note1	D(pulse)	±20	Α
Total Power Dissipation (T _A = 25°C)	P _{T1}	2.0	W
Total Power Dissipation (Tc = 25°C)	P _{T2}	35	W
Channel Temperature	Tch	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C
Single Avalanche Current Note2	las	5.0	Α
Single Avalanche Energy Note2	Eas	16.7	mJ

Notes1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Starting T_{ch} = 25°C, V_{DD} = 150 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

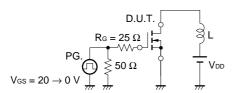


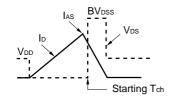
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ELECTRICAL CHARACTERISTICS (TA = 25°C)

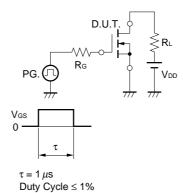
Characteristics	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Zero Gate Voltage Drain Current	Ioss	V _{DS} = 600 V, V _{GS} = 0 V			100	μΑ
Gate Leakage Current	Igss	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
Gate to Source Cut-off Voltage	VGS(off)	V _{DS} = 10 V, I _D = 1 mA	2.5		3.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 2.5 A	1.5			S
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, ID = 2.5 A		1.3	1.6	Ω
Input Capacitance	Ciss	V _{DS} = 10 V		750		pF
Output Capacitance	Coss	Vgs = 0 V		130		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		9.7		pF
Turn-on Delay Time	td(on)	V _{DD} = 150 V, I _D = 2.5 A		17		ns
Rise Time	tr	VGS(on) = 10 V		3		ns
Turn-off Delay Time	td(off)	R _G = 10 Ω		37		ns
Fall Time	tr			10		ns
Total Gate Charge	Q _G	V _{DD} = 450 V		18		nC
Gate to Source Charge	Qgs	Vgs = 10 V		4		nC
Gate to Drain Charge	Q _{GD}	ID = 5.0 A		7		nC
Body Diode Forward Voltage	VF(S-D)	IF = 5.0 A, VGS = 0 V		0.9		V
Reverse Recovery Time	trr	IF = 5.0 A, Vgs = 0 V		1.4		μs
Reverse Recovery Charge	Qrr	di/dt = 50 A/μs		5.3		μC

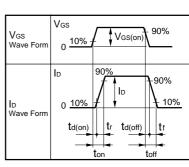
TEST CIRCUIT 1 AVALANCHE CAPABILITY



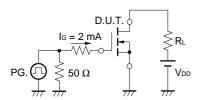


TEST CIRCUIT 2 SWITCHING TIME



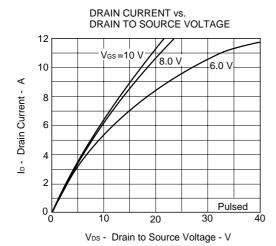


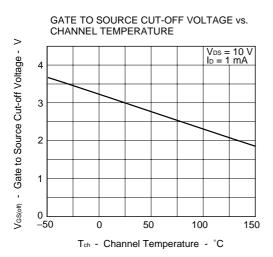
TEST CIRCUIT 3 GATE CHARGE

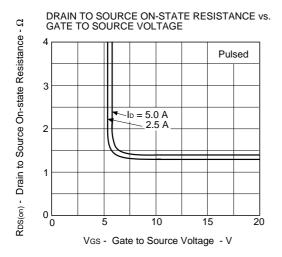


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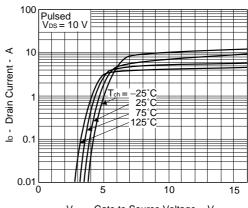
www.DataSheet4U.com TYPICAL CHARACTERISTICS





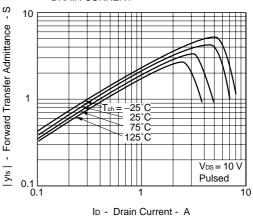


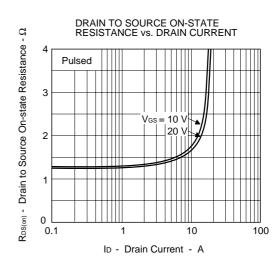
FORWARD TRANSFER CHARACTERISTICS



V_{GS} - Gate to Source Voltage - V

FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



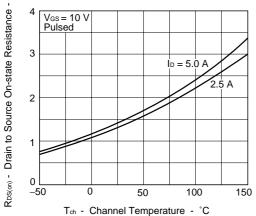


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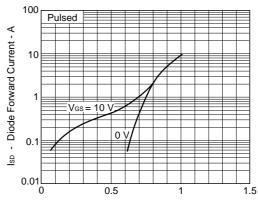
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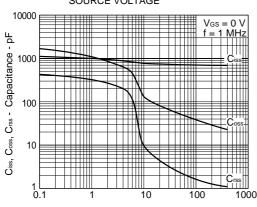


SOURCE TO DRAIN DIODE FORWARD VOLTAGE



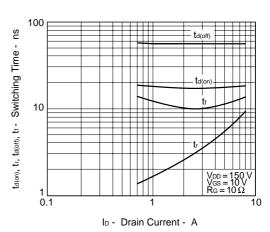
Vsb - Source to Drain Voltage - V

CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

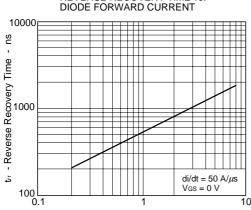


V_{DS} - Drain to Source Voltage - V

SWITCHING CHARACTERISTICS

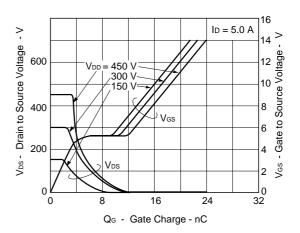


REVERSE RECOVERY TIME vs.



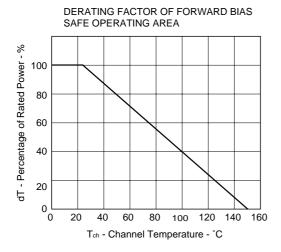
Isp - Diode Forward Current - A

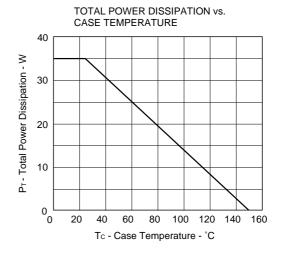
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



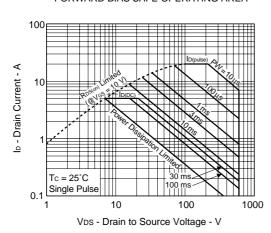


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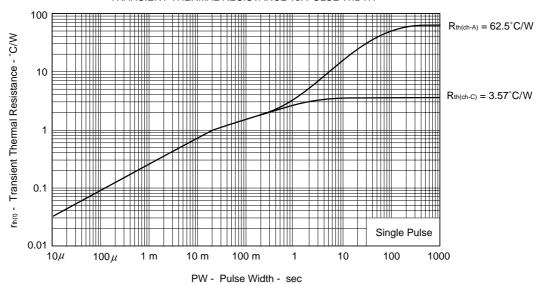




FORWARD BIAS SAFE OPERATING AREA



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

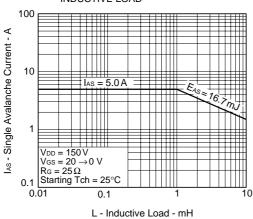


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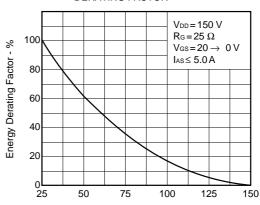
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SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD



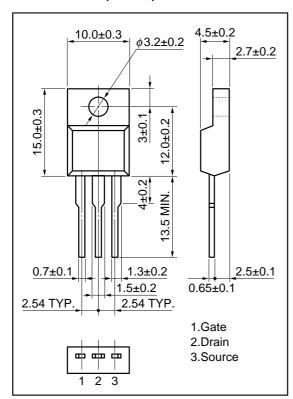
SINGLE AVALANCHE ENERGY DERATING FACTOR



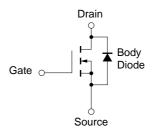
Starting T_{ch} - Starting Channel Temperature - $^{\circ}\text{C}$

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Isolated TO-220 (MP-45F)



EQUIVALENT CIRCUIT



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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